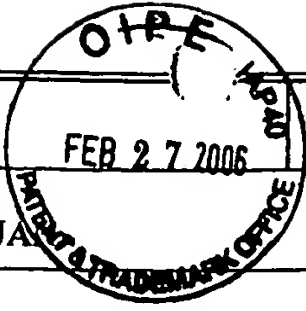
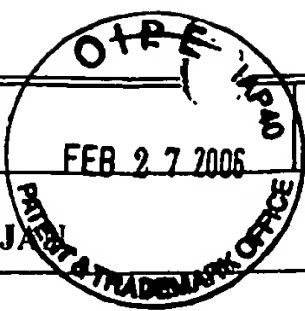


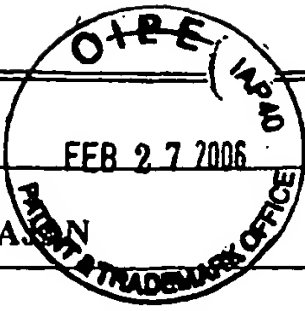
FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)  Date: March 23, 2004		<div style="text-align: center;">  </div> ATTY DOCKET NO. <b>01263.001751</b>  APPLICATION NO. <b>09/866,595</b>  APPLICANT <b>JEBU JACOB RAJA</b>  FILING DATE <b>May 30, 2001</b>  GROUP <b>2655</b>				
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
HV	4,386,237	05/31/1983	Virupaksha et al.	179	15.55 R	
	4,905,286	02/27/1990	Sedgwick et al.	381	43	
	5,012,518	04/30/1991	Liu et al.	381	42	
	5,432,884	07/11/1995	Kapanen et al.	395	2.37	
	5,884,269	03/16/1999	Cellier et al.	704	501	
↓	6,134,518	10/17/2000	Cohen et al.	704	201	
HV	6,226,613 B1	05/01/2001	Turin	704	256	
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
HV	GB 2 137 052 A	09/26/1984	Great Britain			In English
↓	WO 92/22891	12/23/1992	PCT			In English
↓	EP 0 554 083 A2	08/04/1993	Europe			In English
HV	EP 0 631 402 A2	12/28/1994	Europe			In English
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
HV	Srinivasan, et al., "Query Expansion for Imperfect Speech: Applications in Distributed Learning," Proc. IEEE Workshop on Content-Based Access of Image and Video Libraries, 2000, pp. 50-54					
↓	Couvreur, et al., "Wavelet-based Non-Parametric HMM's: Theory and Applications," Proc. International Conference Acoustics, Speech and Signal Processing, Istanbul, Vol. 1, June 5-9, 2000, pp. 604-607					
↓	Hopgood, et al., "Bayesian Single Channel Blind Deconvolution Using Parametric Signal and Channel Models," Proc. IEEE Workshop on Applications of Signal Processing to Audio and Acoustics, New Paltz, NY, October 17-20, 1999, pp. 151-154					
HV	Andrieu, et al., "Bayesian Blind Marginal Separation of Convolutively Mixed Discrete Sources," IEEE Proc., 1998, pp. 43-52					
EXAMINER			DATE CONSIDERED			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
HV	EP 0 674 306 A2	09/27/1995	Europe			In English
<div style="font-size: 2em;">}</div>	WO 98/38631	09/03/1998	PCT			In English
	GB 2 332 054 A	06/09/1999	Great Britain			In English
	GB 2 332 055 A	06/09/1999	Great Britain			In English
	WO 99/28760	06/10/1999	PCT			In English
	WO 99/28761	06/10/1999	PCT			In English
	EP 0 952 589 A2	10/27/1999	Europe			In English
	WO 99/64887	12/16/1999	PCT			In English
	WO 00/11650	03/02/2000	PCT			In English
	EP 0 996 112 A2	04/26/2000	Europe			In English
	WO 00/38179	06/29/2000	PCT			In English
	GB 2 345 967 A	07/26/2000	Great Britain			In English
HV	EP 1 022 583 A2	07/26/2000	Europe			In English
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER			DATE CONSIDERED			
<div style="font-size: 1.5em;">Huyen X. Vo</div>			<div style="font-size: 1.5em;">4/3/06</div>			

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APPLICANT <b>JEBU JACOB RAYSON</b>		FILING DATE <b>May 30, 2001</b>		GROUP <b>2655</b>	



U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
HV	WO 00/45375	08/03/2000	PCT			In English
	WO 00/54168	09/14/2000	PCT			In English
	GB 2 349 717 A	11/08/2000	Great Britain			In English
	JP 2001/044926	02/16/2001	Japan			Abstract
	GB 2 356 106 A	05/09/2001	Great Britain			In English
	GB 2 356 107 A	05/09/2001	Great Britain			In English
	GB 2 356 313 A	05/16/2001	Great Britain			In English
	GB 2 356 314 A	05/16/2001	Great Britain			In English
	GB 2 360 670 A	09/26/2001	Great Britain			In English
	GB 2 361 339 A	10/17/2001	Great Britain			In English
	EP 1 160 768 A2	12/05/2001	Europe			In English
	GB 2 363 557 A	12/19/2001	Great Britain			In English
HV	EP 1 034 441 B1	04/02/2003	Europe			In English

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)	

EXAMINER	DATE CONSIDERED
Huyen X. Vo	4/3/06

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